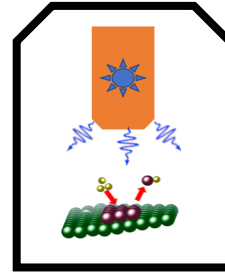


- Intellectual property decision group



Invention Report : 20210814
Hydrocarbon Mitigation System (HMS)
for Electron Microscopy

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PATENT HOLD; ARGONNE BUSINESS SENSITIVE; PRIVILEGED; DO NOT REPRODUCE
This material includes information of patent interest protected under 35 U.S.C. 205 relating to an invention of Argonne National Laboratory and shall be used, duplicated, and disclosed only for purposes of evaluation. Disclosure to persons outside the Government shall not be made before approval for such release has been secured from Patent Counsel, Argonne National Laboratory, 9700 South Cass Avenue, Lemont, IL 60439.

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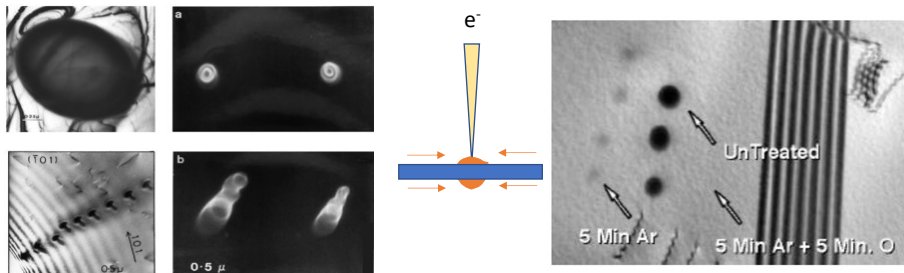
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1

PRIOR ART: Background - Hydrocarbon Mitigation for Electron Microscopy

In 1995, ANL developed the plasma cleaner (U.S. Pat. # 5,510,624) for reduction/removal of hydrocarbon contamination in robust materials and instruments by using reactive gas plasma's for use in electron microscopy. The contamination is formed by surface hydrocarbons migrating to the electron probe.



Examples of "mobile hydrocarbon contamination"

Before / After Plasma cleaning

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Licensee's of the ANL Plasma Cleaning Technology for Electron Optical Beam Lines

South Bay Technology
Fischione Instruments
XEI Scientific
Structure Probe Inc
Gatan Inc.
Zyvex Group.

- Invented the Technology
- Proved the Methodology
- Advised Manufacturers on design
- Tested products as part of the license agreements



Six companies selling in the USA licensed this. Non-US companies did not license as the no international filing were done.

Units sell for \$50-125K. Number of units sold? Every Materials Science EM facility I have visited has at least one.

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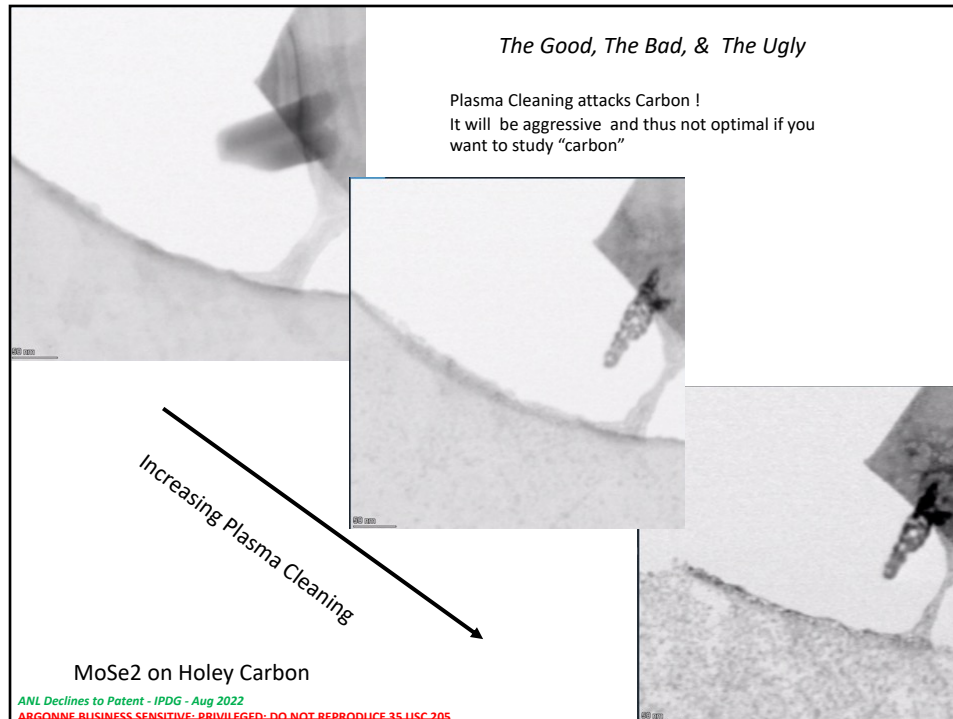
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3

The Good, The Bad, & The Ugly

Plasma Cleaning attacks Carbon !
It will be aggressive and thus not optimal if you want to study "carbon"



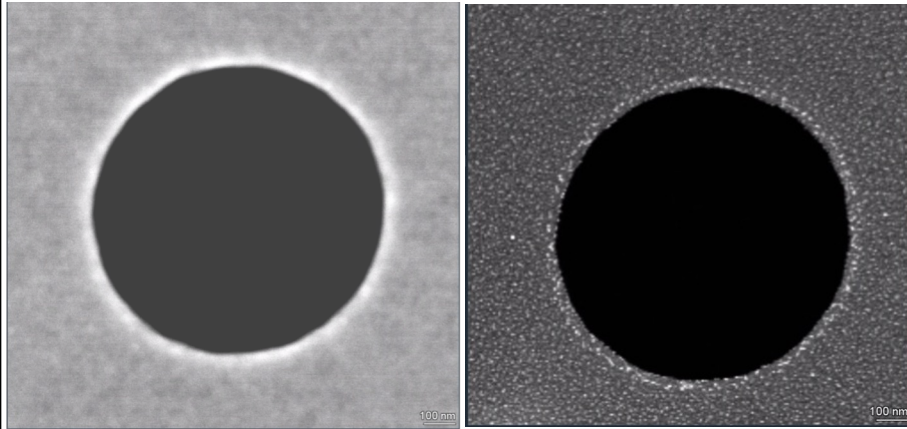
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4

The Good, The Bad, & The Ugly

Plasma Cleaning attacks Carbon !



Increasing Plasma Cleaning

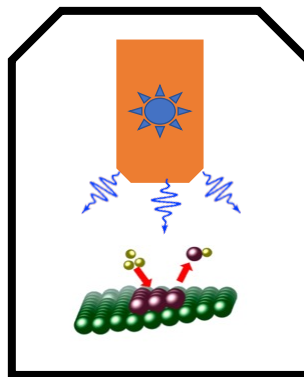
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New Invention Report : 20210814

Hydrocarbon Mitigation System (HMS)
for Electron Microscopy



A new method has been developed which can be used which is gentler, and significantly less expensive (< \$1000) than plasma cleaning. It is applicable to specimens which are *lightly contaminated* with mobile surface hydrocarbons such as Graphene and carbon nanotubes, organic films which are be significantly affected by an energetic plasma.

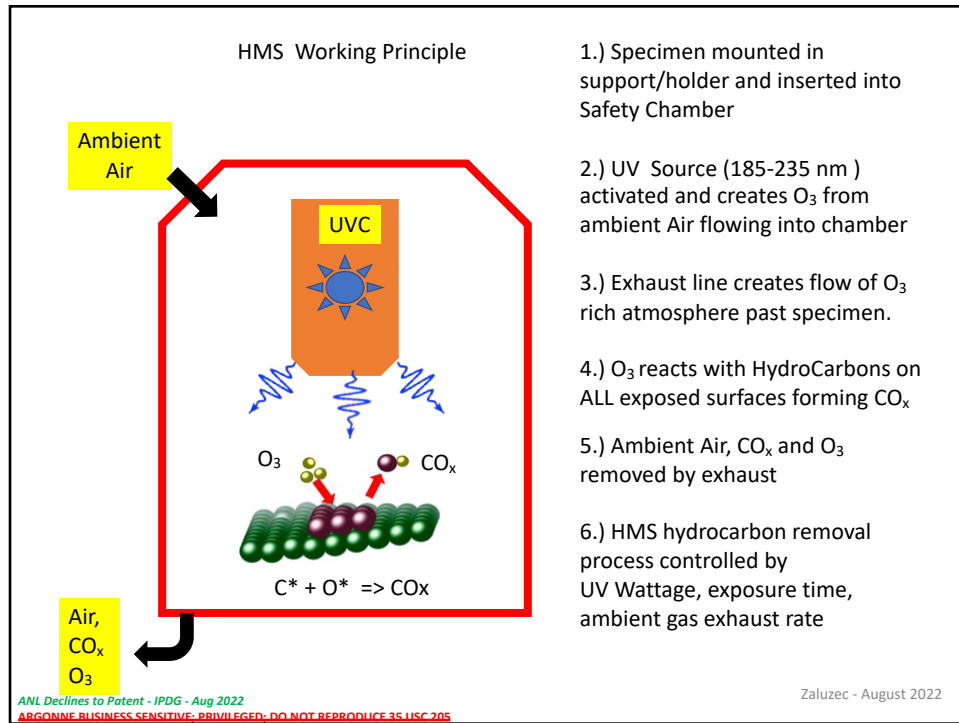
Similar principle to Plasma cleaning but without the plasma!

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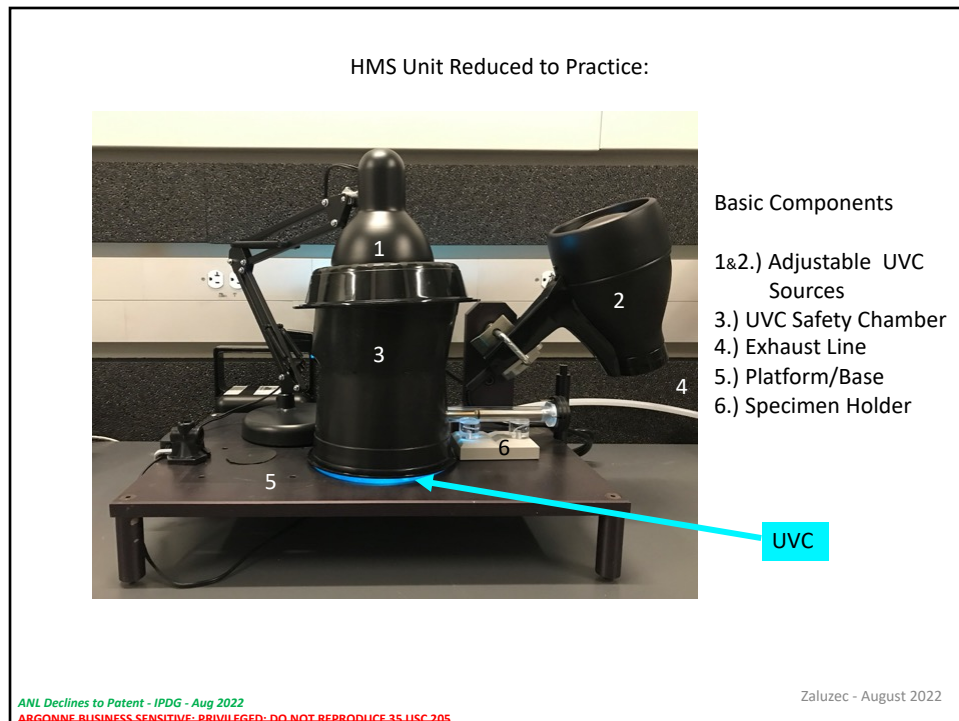
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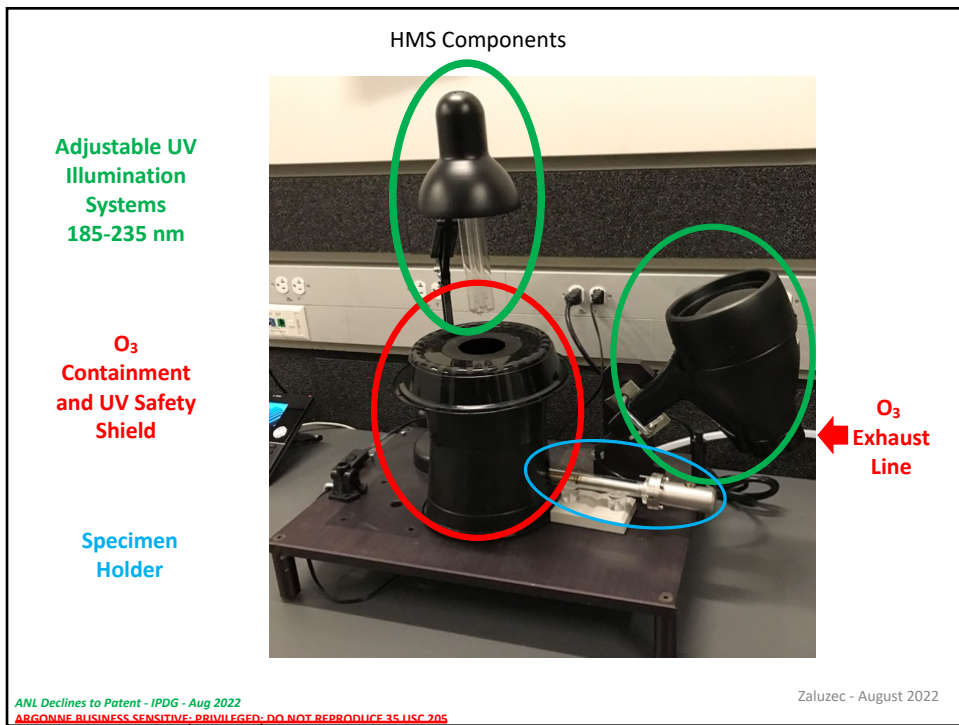
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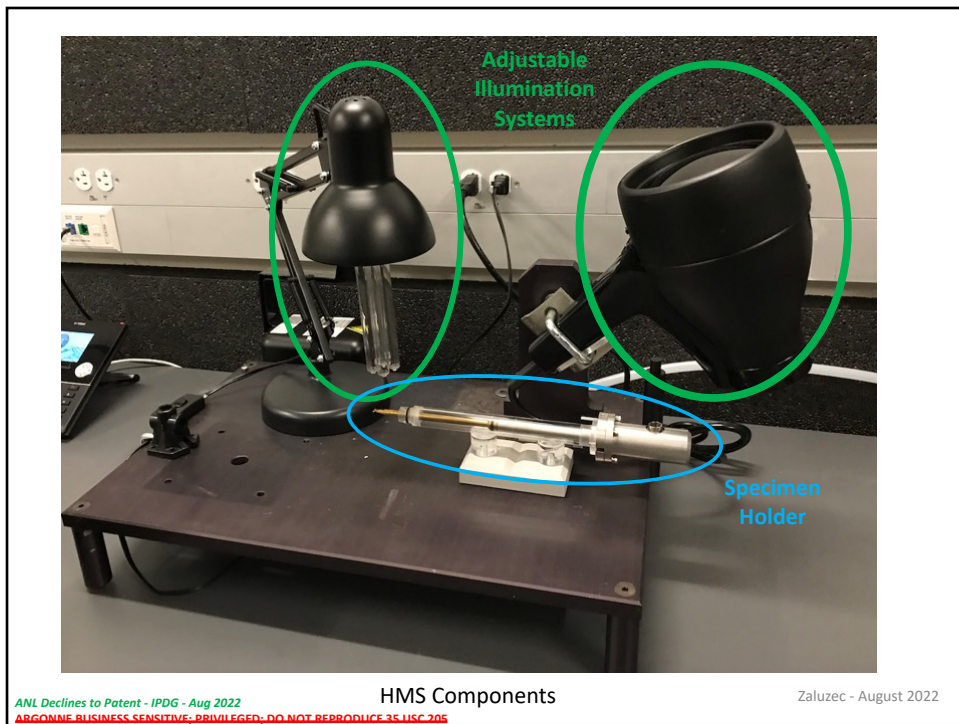
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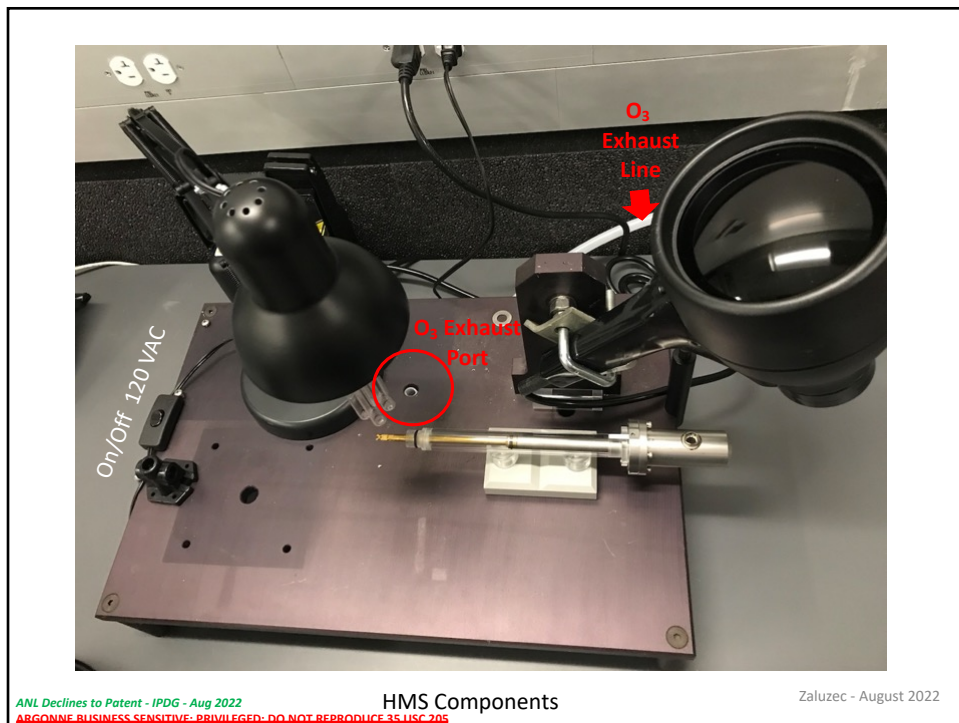
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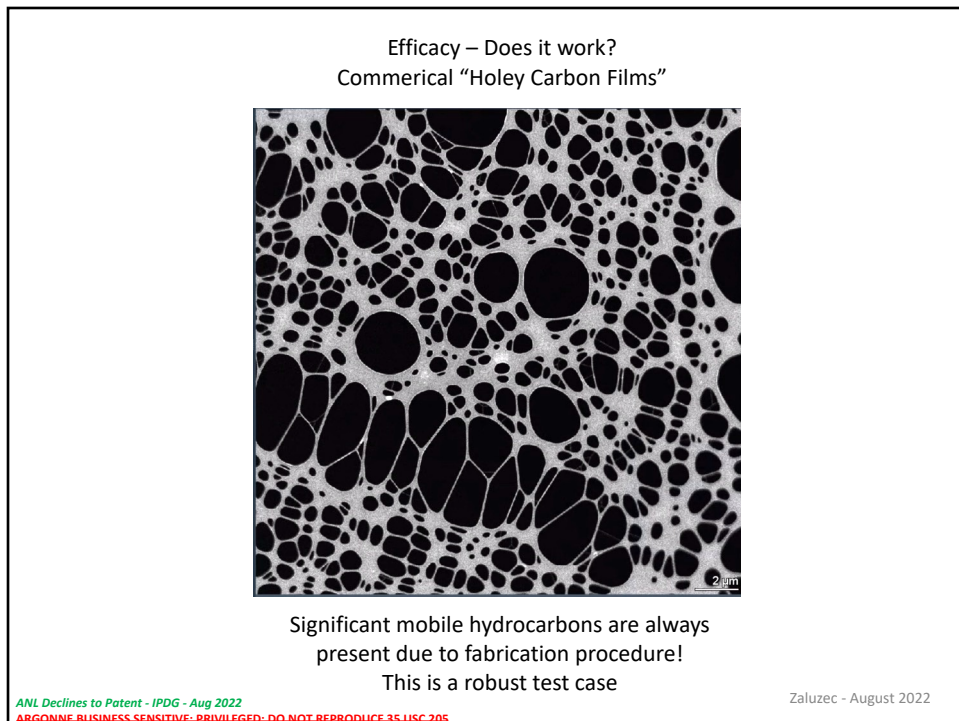
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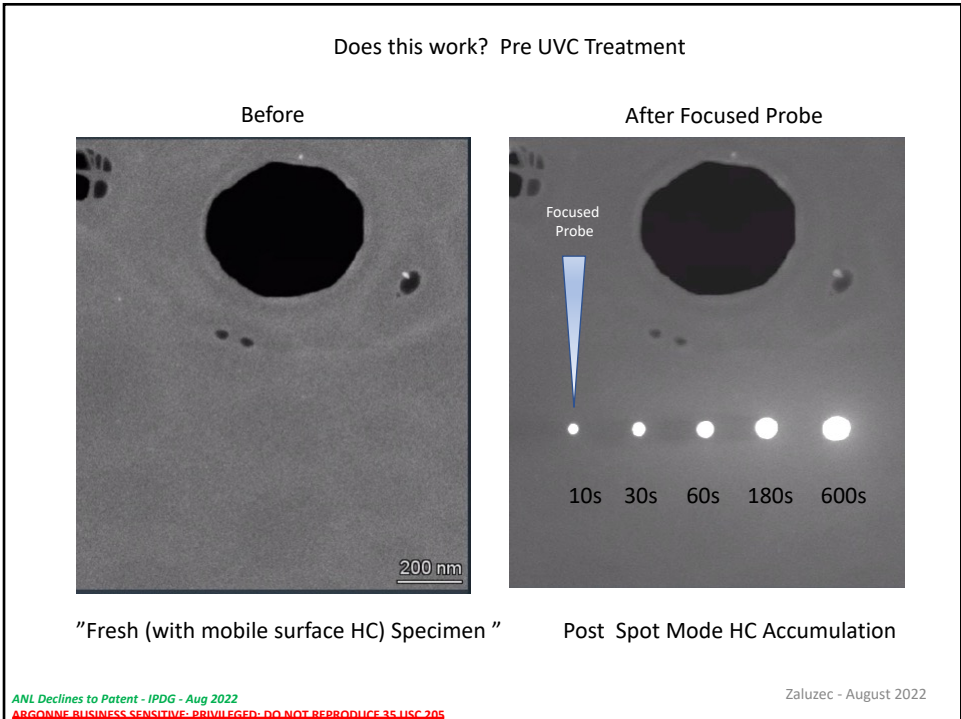
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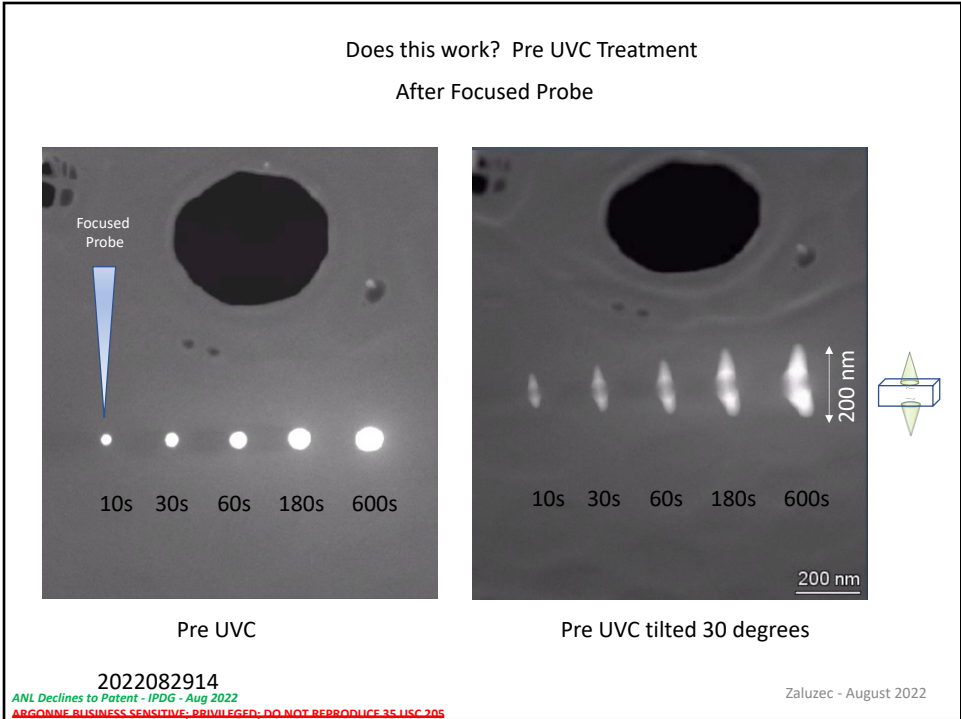
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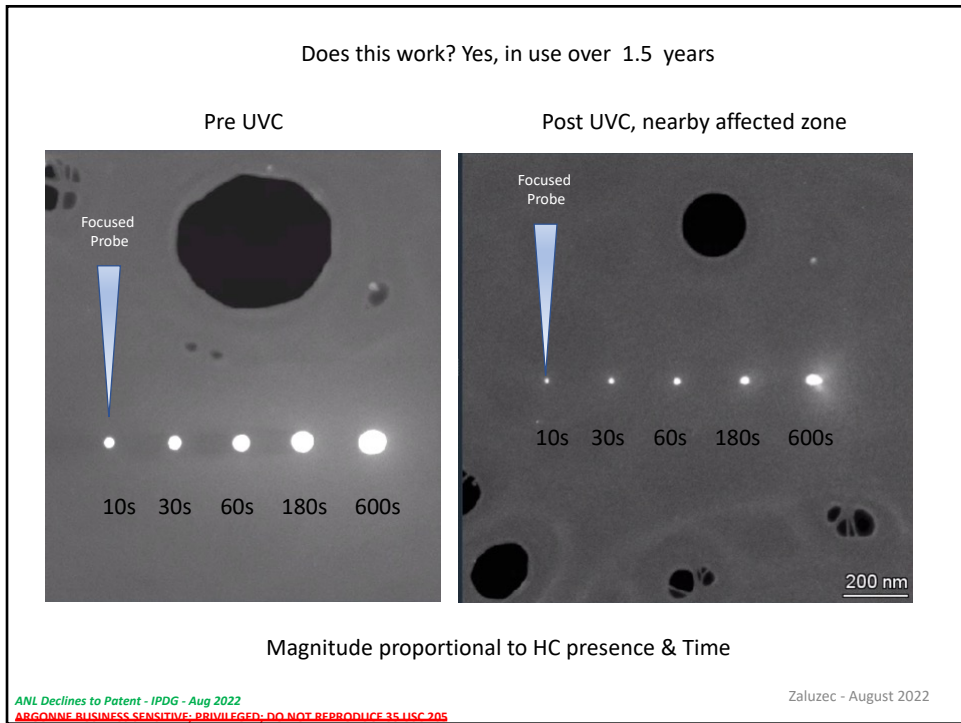
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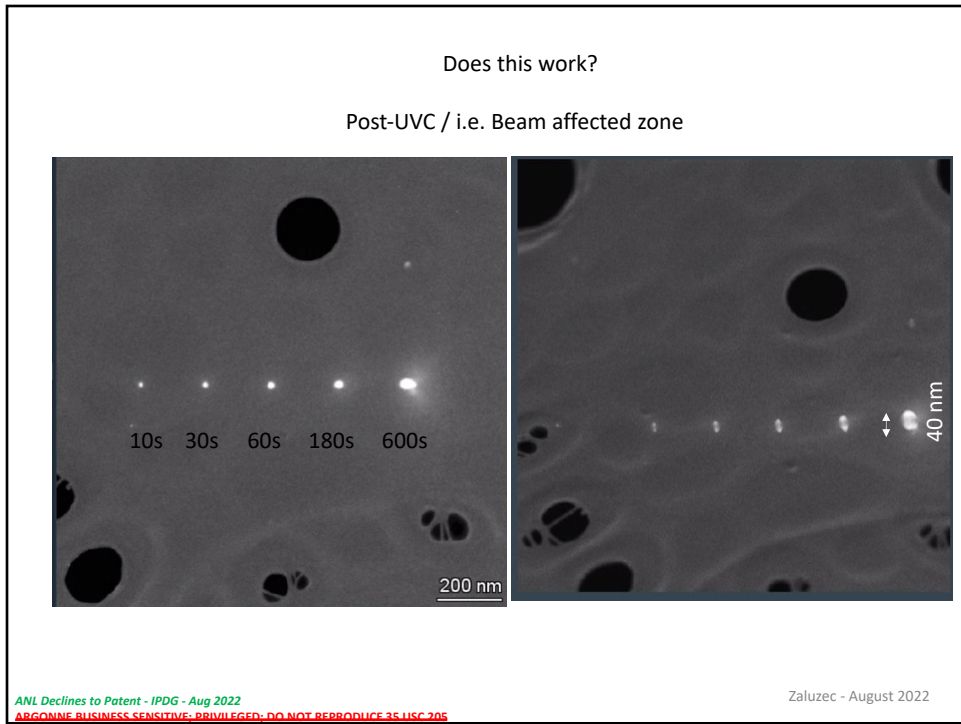
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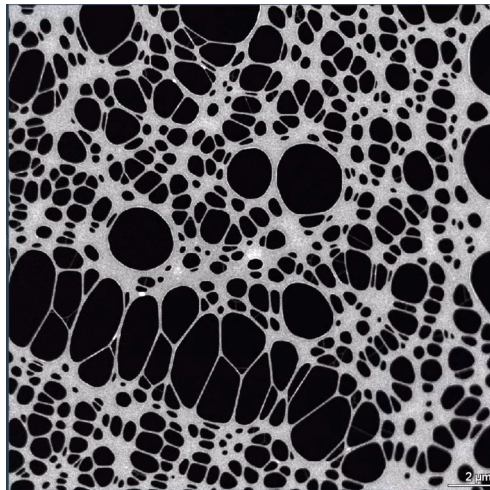


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The Pre UVC irradiation creates a Beam Affected Zone



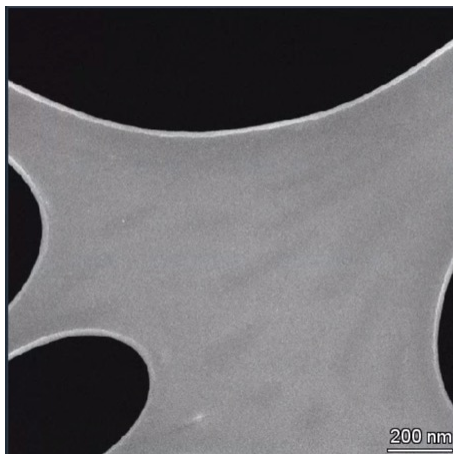
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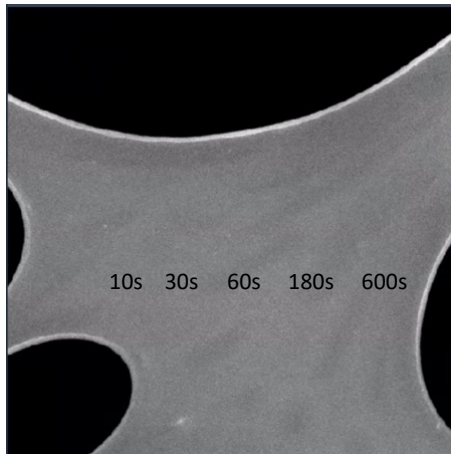
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Post UVC but move away
Distance (> 5 Microns) from Beam Affected Zone



Pre Spot Mode



Post Spot Mode

"Far" from Beam Affected Zone

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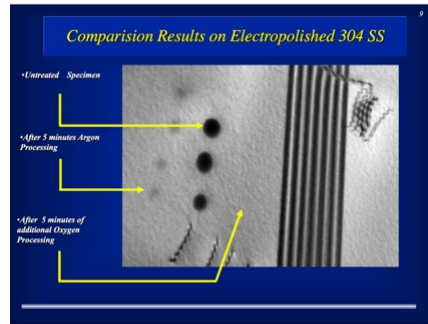
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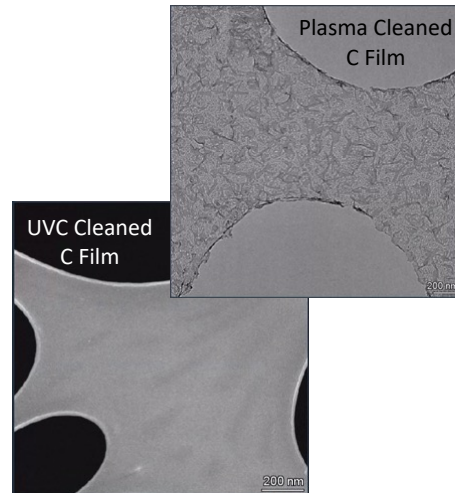
Which is Better:

Plasma Cleaning..... Robust metals, ceramics, very Thick materials

UVC – Light contamination, Carbonaceous Films, 2 D Materials (Graphene !), Soft Matter



Plasma Cleaned Robust Metal



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Advantages

Inexpensive, easy to implement.

Works on "C" sensitive materials & not aggressive.

Important for any "material" which may have HC's involved
Energy Materials, Soft Matter, BioSystems

Commercial Interest

Likely, have not talked about this to commercial vendors

Plasma Cleaner Process is a commercial success but
an IP Failure for the Lab due to insufficient protection

Is this worthwhile..... \$\$\$?

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